


<b>Search Notes</b>  	<b>Application/Control No.</b>  10750378	<b>Applicant(s)/Patent Under Reexamination</b>  KOL ET AL.
	<b>Examiner</b>  Van Kim T Nguyen	<b>Art Unit</b>  2456

SEARCHED			
Class	Subclass	Date	Examiner
709	203, 217, 218, 219, 227, 228	2/24/11	VN

SEARCH NOTES		
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INTERFERENCE SEARCH			
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